



Temperature and Process Compensation in MADT-011000

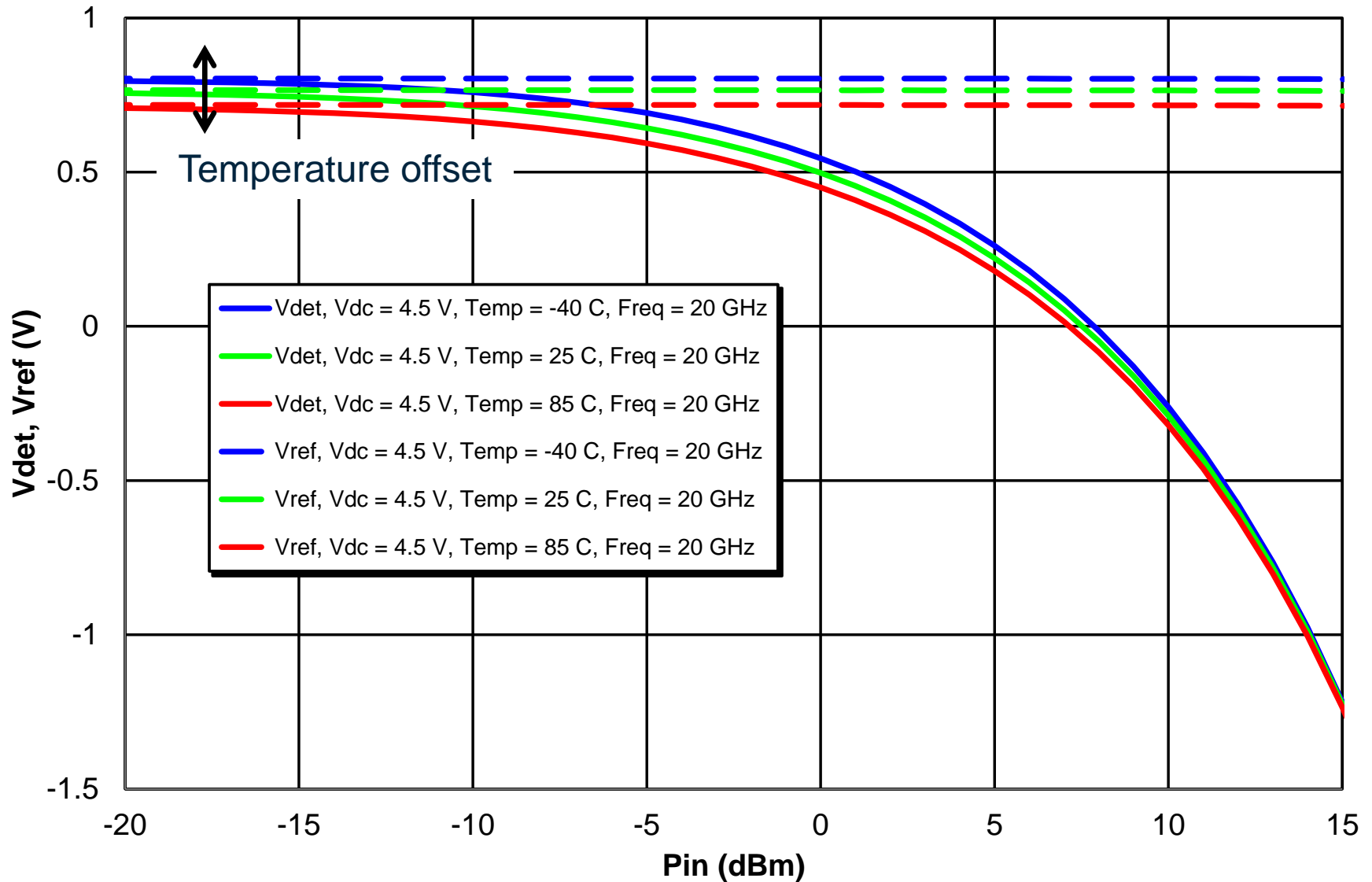
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- MADT-011000 has two voltage outputs: V_{det} and V_{ref} .
- The voltage V_{det} varies between approximately +0.75 V with no RF input, to -1.25 V with +15 dBm RF input level. The voltage V_{ref} does not vary with input power level.
- Temperature changes introduce a small voltage offset to V_{det} (approximately +/-25 mV), which might need to be accounted for if high accuracy is needed at low power levels.
- Similarly, fabrication tolerances result in part-to-part variation in quiescent V_{det} levels that must be accounted for to maximise the dynamic range of the detector.
- The two outputs V_{det} and V_{ref} have the same temperature-related voltage offset, and are matched in terms of fabrication tolerances. Therefore, the difference voltage $V_{\Delta} = V_{ref} - V_{det}$ is insensitive to changes in temperature as well as manufacturing variations.

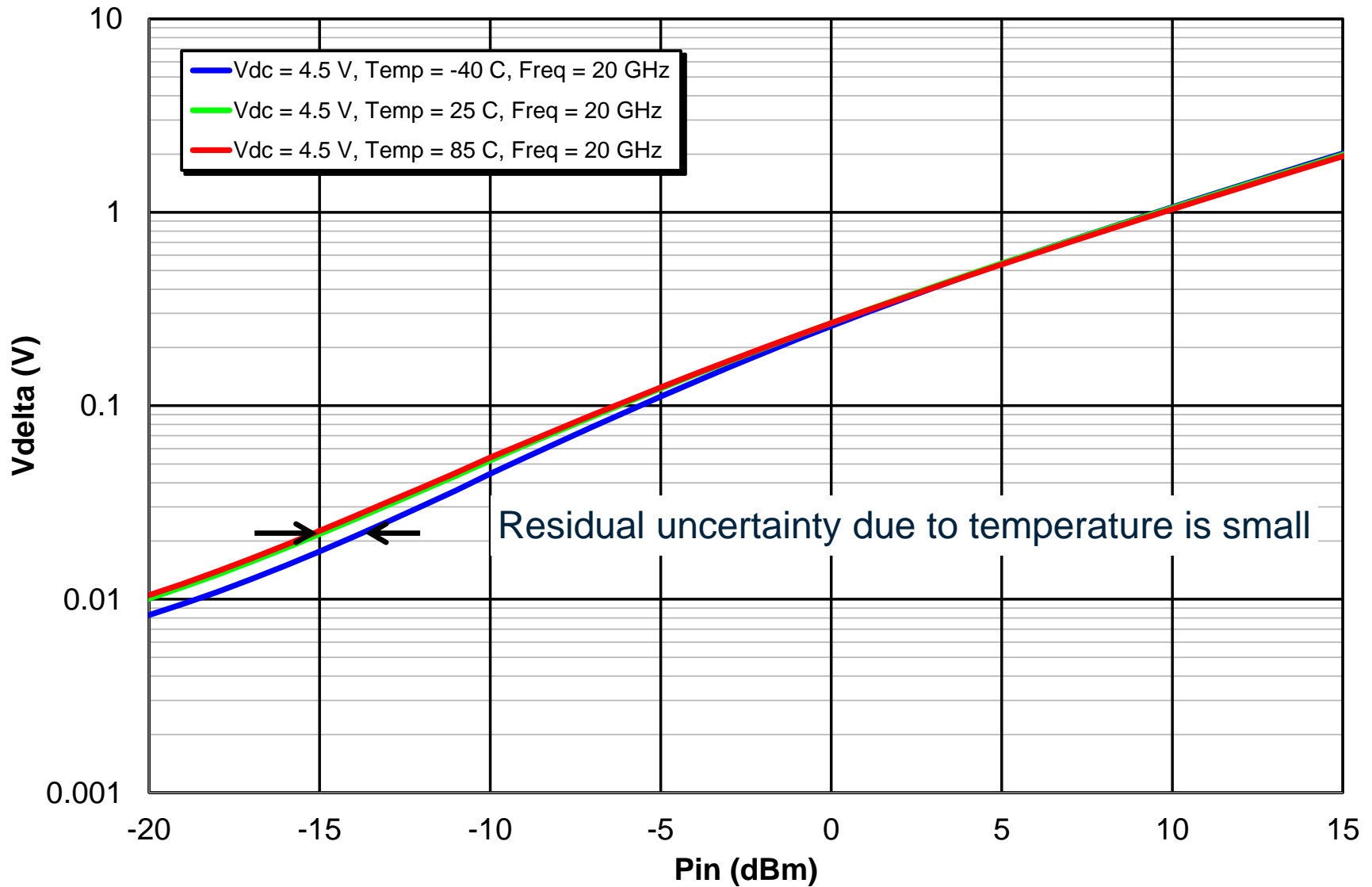
Vdet and Vref vs. Input Power

-40, +25 & +85 °C shown

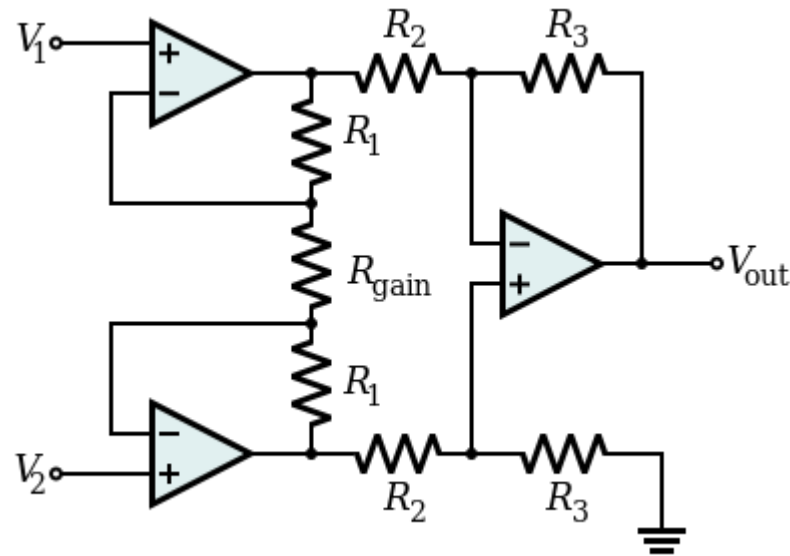


Vdelta vs. Input Power

-40, +25 & +85 °C shown



- It is recommended to use a high input impedance differencing circuit, such as an instrumentation amplifier, to generate V_{Δ} .



- Alternatively, V_{det} and V_{ref} can be directly applied to the differential inputs of an ADC, or to two separate ADCs with the subtraction implemented digitally.